## IGBT - Field Stop, Trench 650 V, 40 A

# FGH40T65SQD

### Description

Using novel field stop IGBT technology, ON Semiconductor's new series of field stop 4<sup>th</sup> generation IGBTs offer the optimum performance for solar inverter, UPS, welder, telecom, ESS and PFC applications where low conduction and switching losses are essential.

### Features

- Max Junction Temperature 175°C
- Positive Temperature Co-efficient for Easy Parallel Operating
- High Current Capability
- Low Saturation Voltage:  $V_{CE(sat)} = 1.6 \text{ V} (Typ.) @ I_C = 40 \text{ A}$
- 100% of the Parts Tested for I<sub>LM</sub>
- High Input Impedance
- Fast Switching
- Tighten Parameter Distribution
- This Device is Pb-Free and is RoHS Compliant

#### Applications

• Solar Inverter, UPS, Welder, Telecom, ESS, PFC

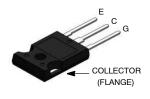


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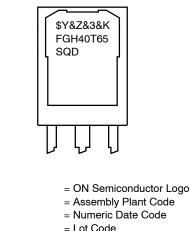
V <sub>CES</sub>	Ι <sub>C</sub>
650 V	40 A





TO-247-3LD CASE 340CH

#### MARKING DIAGRAM



&K	= Lot Code
FGH40T65SQD	= Specific Device Code

\$Y

&Z

&3

#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 2 of this data sheet.

#### **ABSOLUTE MAXIMUM RATINGS**

Symbol	Description		FGH40T65SQD-F155	Unit
V <sub>CES</sub>	Collector to Emitter Voltage		650	V
V <sub>GES</sub>	Gate to Emitter Voltage		±20	V
	Transient Gate to Emitter Voltage		±30	V
Ι <sub>C</sub>	Collector Current	$T_{C} = 25^{\circ}C$	80	А
		T <sub>C</sub> = 100°C	40	А
I <sub>LM</sub> (Note 1)	Pulsed Collector Current	T <sub>C</sub> = 25°C	160	А
I <sub>CM</sub> (Note 2)	Pulsed Collector Current	r Current		А
١ <sub>F</sub>	Diode Forward Current	$T_{C} = 25^{\circ}C$	40	А
	Diode Forward Current	T <sub>C</sub> = 100°C	20	А
I <sub>FM</sub> (Note 2)	Pulsed Diode Maximum Forward Current		160	А
PD	Maximum Power Dissipation	$T_{C} = 25^{\circ}C$	238	W
		T <sub>C</sub> = 100°C	119	W
TJ	Operating Junction Temperature	•	–55 to +175	°C
T <sub>STG</sub>	Storage Temperature Range		–55 to +175	°C
ΤL	Maximum Lead Temp. for Soldering Purposes	s, 1/8" from Case for 5 Seconds	300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected. 1.  $V_{CC} = 400 \text{ V}$ ,  $V_{GE} = 15 \text{ V}$ ,  $I_C = 160 \text{ A}$ ,  $R_G = 22 \Omega$ , Inductive Load. 2. Repetitive rating: Pulse width limited by max. junction temperature.

### THERMAL CHARACTERISTICS

Symbol	Parameter	FGH40T65SQD-F155	Unit
R <sub>θJC</sub> (IGBT)	Thermal Resistance, Junction to Case, Max.	0.63	°C/W
$R_{\theta JC}$ (Diode)	Thermal Resistance, Junction to Case, Max.	1.71	°C/W
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient, Max.	40	°C/W

### PACKAGE MARKING AND ORDERING INFORMATION

Device Marking	Device	Package	Reel Size	Tape Width	Qty per Tube
FGH40T65SQD	FGH40T65SQD-F155	TO-247-3LD	-	-	30

### ELECTRICAL CHARACTERISTICS OF THE IGBT (T<sub>C</sub> = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
OFF CHARACT	ERISTICS		•	•		
BV <sub>CES</sub>	Collector to Emitter Breakdown Voltage	V <sub>GE</sub> = 0 V, I <sub>C</sub> = 1 mA	650	-	-	V
$\Delta \text{BV}_{\text{CES}}  /  \Delta \text{T}_{\text{J}}$	Temperature Coefficient of Breakdown Voltage	V <sub>GE</sub> = 0 V, I <sub>C</sub> = 1 mA	-	0.6	-	V/°C
I <sub>CES</sub>	Collector Cut-Off Current	V <sub>CE</sub> = V <sub>CES</sub> , V <sub>GE</sub> = 0 V	-	-	250	μA
I <sub>GES</sub>	G-E Leakage Current	V <sub>GE</sub> = V <sub>GES</sub> , V <sub>CE</sub> = 0 V	-	-	±400	nA
ON CHARACTE	RISTICS			•		•
V <sub>GE(th)</sub>	G-E Threshold Voltage	$I_C$ = 40 mA, $V_{CE}$ = $V_{GE}$	2.6	4.5	6.4	V
V <sub>CE(sat)</sub>	Collector to Emitter Saturation Voltage	I <sub>C</sub> = 40 A, V <sub>GE</sub> = 15 V	-	1.6	2.1	V
		I <sub>C</sub> = 40 A, V <sub>GE</sub> = 15 V, T <sub>C</sub> = 175°C	-	1.92	_	v
DYNAMIC CHA	RACTERISTICS		•	•		•
Cies	Input Capacitance	V <sub>CE</sub> = 30 V, V <sub>GE</sub> = 0 V,	-	2620	-	pF
C <sub>oes</sub>	Output Capacitance	f = 1MHz	-	60	_	pF
C <sub>res</sub>	Reverse Transfer Capacitance	-	-	9	-	pF
SWITCHING CH	IARACTERISTICS		•	•		•
T <sub>d(on)</sub>	Turn-On Delay Time	$V_{CC} = 400 \text{ V}, \text{ I}_{C} = 10 \text{ A}, \\ R_{G} = 6 \Omega, \text{ V}_{GE} = 15 \text{ V}, \\ \text{Inductive Load, } T_{C} = 25^{\circ}\text{C}$	-	16.4	-	ns
T <sub>r</sub>	Rise Time		-	4.8	_	ns
T <sub>d(off)</sub>	Turn–Off Delay Time		-	86.4	-	ns
Τ <sub>f</sub>	Fall Time		-	8.8	-	ns
Eon	Turn–On Switching Loss		-	138	-	μJ
E <sub>off</sub>	Turn–Off Switching Loss		-	52	-	μJ
E <sub>ts</sub>	Total Switching Loss		-	190	-	μJ
T <sub>d(on)</sub>	Turn-On Delay Time	$V_{CC} = 400 \text{ V}, I_C = 20 \text{ A},$	-	17.6	-	ns
Tr	Rise Time	$R_G = 6 \Omega$ , $V_{GE} = 15 V$ , Inductive Load, $T_C = 25^{\circ}C$	-	9.6	-	ns
T <sub>d(off)</sub>	Turn-Off Delay Time		-	80	-	ns
Τ <sub>f</sub>	Fall Time		-	8.8	-	ns
Eon	Turn–On Switching Loss		-	329	-	μJ
E <sub>off</sub>	Turn–Off Switching Loss		-	84	-	μJ
E <sub>ts</sub>	Total Switching Loss		-	413	-	μJ
T <sub>d(on)</sub>	Turn–On Delay Time	V <sub>CC</sub> = 400 V, I <sub>C</sub> = 10 A, R <sub>G</sub> = 6 Ω, V <sub>GE</sub> = 15 V,	-	14.4	-	ns
T <sub>r</sub>	Rise Time	Inductive Load, $T_C = 175^{\circ}C$	-	6.4	-	ns
T <sub>d(off)</sub>	Turn–Off Delay Time		-	99.2	-	ns
Т <sub>f</sub>	Fall Time		-	8	-	ns
Eon	Turn-On Switching Loss		-	269	-	μJ
E <sub>off</sub>	Turn–Off Switching Loss	1	-	132	-	μJ
E <sub>ts</sub>	Total Switching Loss	-		401	_	μJ

## **ELECTRICAL CHARACTERISTICS OF THE IGBT** ( $T_C = 25^{\circ}C$ unless otherwise noted) (continued)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit			
SWITCHING C	VITCHING CHARACTERISTICS								
T <sub>d(on)</sub>	Turn-On Delay Time	V <sub>CC</sub> = 400 V, I <sub>C</sub> = 20 A, R <sub>G</sub> = 6 Ω, V <sub>GE</sub> = 15 V,	-	16	-	ns			
Tr	Rise Time	Inductive Load, $T_C = 175^{\circ}C$	-	11.2	-	ns			
T <sub>d(off)</sub>	Turn-Off Delay Time		-	91.2	-	ns			
T <sub>f</sub>	Fall Time		-	8	-	ns			
Eon	Turn–On Switching Loss		-	581	-	μJ			
E <sub>off</sub>	Turn–Off Switching Loss		-	237	-	μJ			
E <sub>ts</sub>	Total Switching Loss		-	818	-	μJ			
Qg	Total Gate Charge	V <sub>CE</sub> = 400 V, I <sub>C</sub> = 40 A, V <sub>GE</sub> = 15 V	-	80	-	nC			
Q <sub>ge</sub>	Gate to Emitter Charge	VGE - 13 V	-	15	-	nC			
Q <sub>gc</sub>	Gate to Collector Charge		-	20	-	nC			

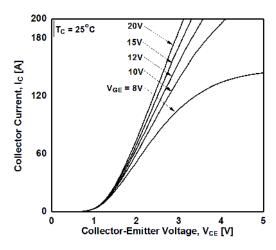
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

### **ELECTRICAL CHARACTERISTICS OF THE DIODE** (T<sub>C</sub> = $25^{\circ}$ C unless otherwise noted)

Symbol	Parameter	Test Co	Min	Тур	Max	Unit	
V <sub>FM</sub>	Diode Forward Voltage	I <sub>F</sub> = 20 A	$T_C = 25^{\circ}C$	-	2.2	2.8	V
			T <sub>C</sub> = 175°C	-	1.94	-	
E <sub>rec</sub>	Reverse Recovery Energy	I <sub>F</sub> = 20 A, dI <sub>F</sub> /dt = 200 A/μs	T <sub>C</sub> = 175°C	-	50	-	μJ
T <sub>rr</sub>	Diode Reverse Recovery Time		$T_{C} = 25^{\circ}C$	-	31.8	-	ns
			T <sub>C</sub> = 175°C	-	192	-	
Q <sub>rr</sub>	Diode Reverse Recovery Charge	1	$T_{C} = 25^{\circ}C$	-	50.6	-	nC
			T <sub>C</sub> = 175°C	-	699	-	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### **TYPICAL CHARACTERISTICS**





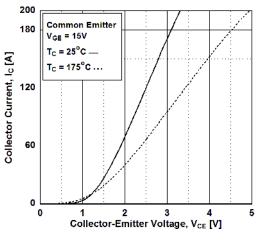


Figure 3. Typical Saturation Voltage Characteristics

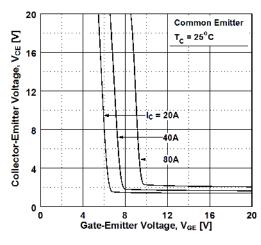


Figure 5. Saturation Voltage vs.  $V_{GE}$ 

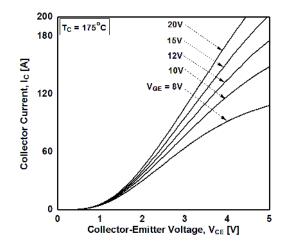


Figure 2. Typical Output Characteristics

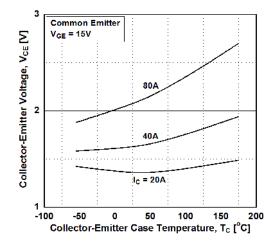


Figure 4. Saturation Voltage vs. Case Temperature at Variant Current Level

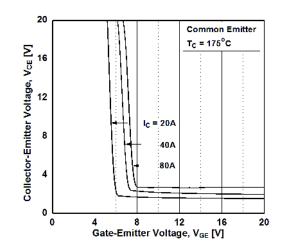
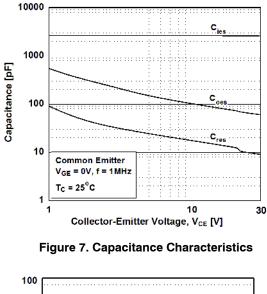
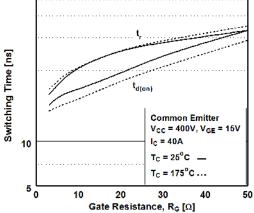


Figure 6. Saturation Voltage vs. V<sub>GE</sub>

### TYPICAL CHARACTERISTICS (Continued)







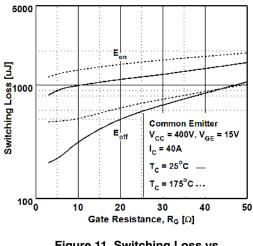


Figure 11. Switching Loss vs. Gate Resistance

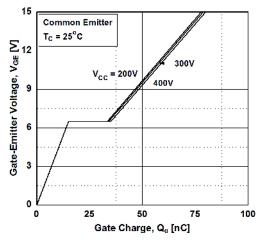


Figure 8. Gate Charge Characteristics

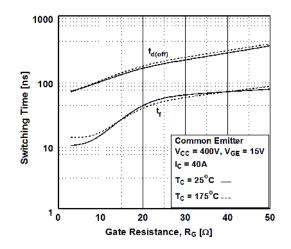
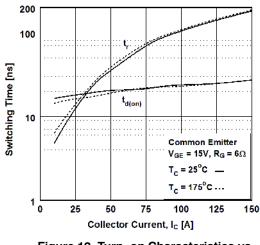
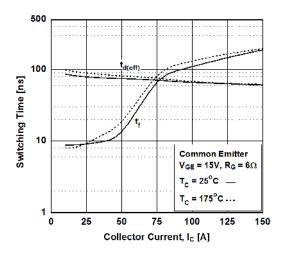


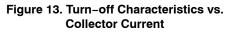
Figure 10. Turn-off Characteristics vs. Gate Resistance





### TYPICAL CHARACTERISTICS (Continued)





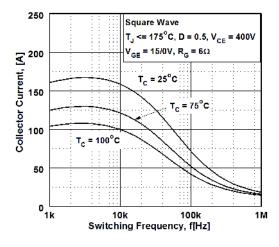


Figure 15. Load Current vs. Frequency

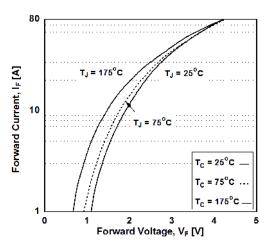
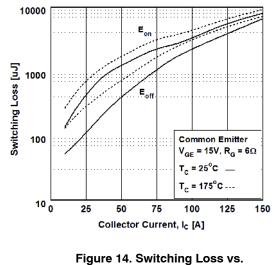


Figure 17. Forward Characteristics



Collector Current

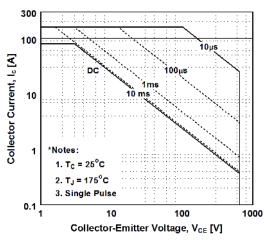


Figure 16. SOA Characteristics

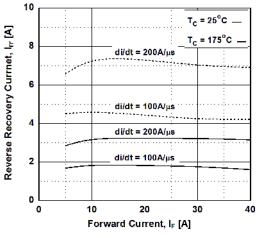


Figure 18. Reverse Recovery Current

#### TYPICAL CHARACTERISTICS (Continued)

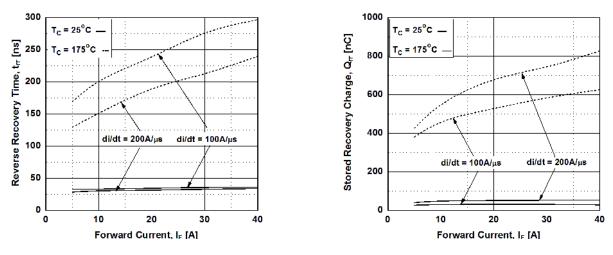


Figure 19. Reverse Recovery Time

Figure 20. Stored Charge

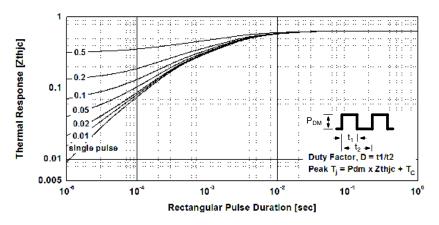


Figure 21. Transient Thermal Impedance of IGBT

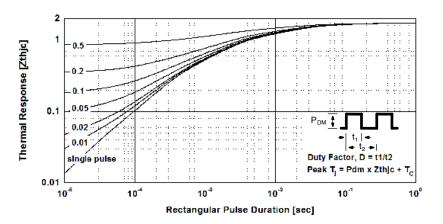
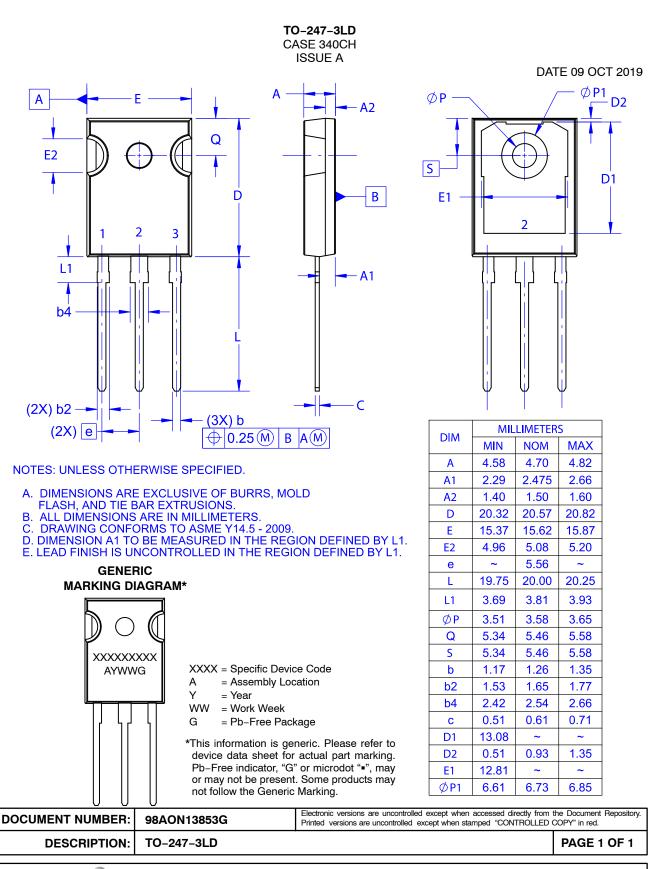


Figure 22. Transient Thermal Impedance of Diode





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